

Characterization of ELMs and their Effects on NSTX using Multi-color Ultrasoft X-ray Imaging

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The Johns Hopkins University

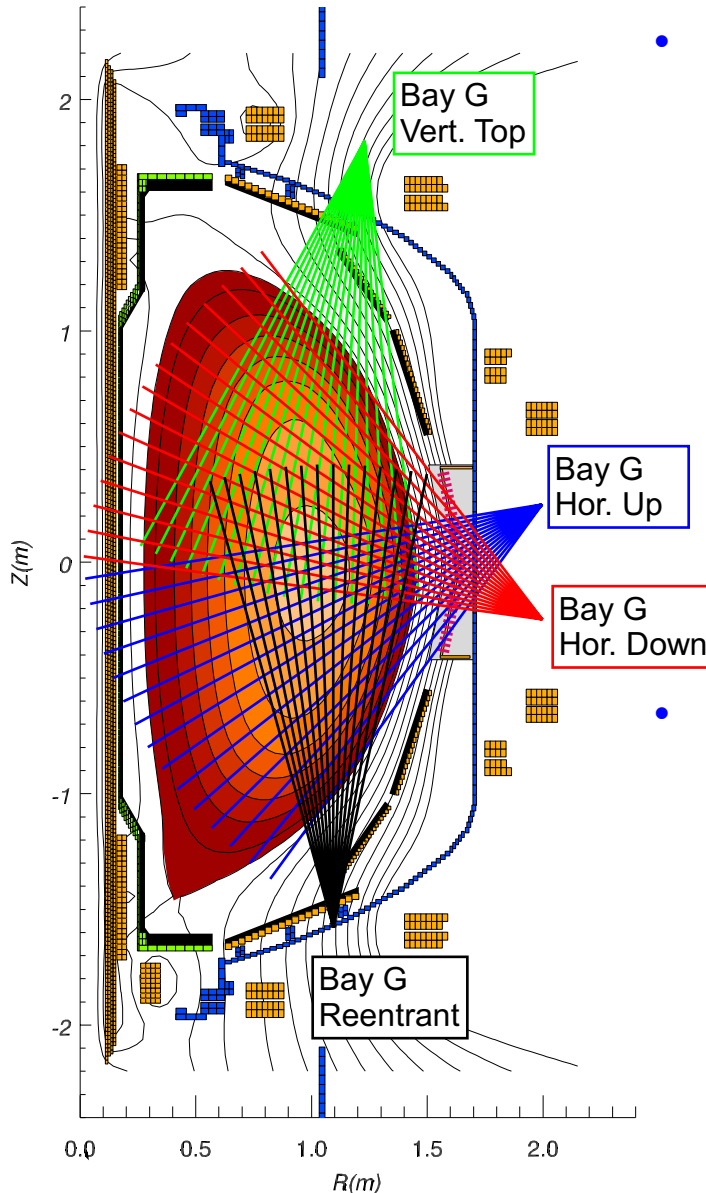
R. Maingi (*ORNL*)

and the NSTX Team

NSTX Results Forum Sept. 19th-20th

Upgraded Bay G USXR System Provides Improved Spatial Coverage

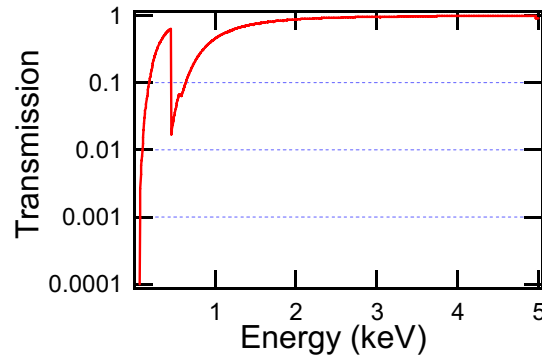
Shot= 112581, time= 538ms



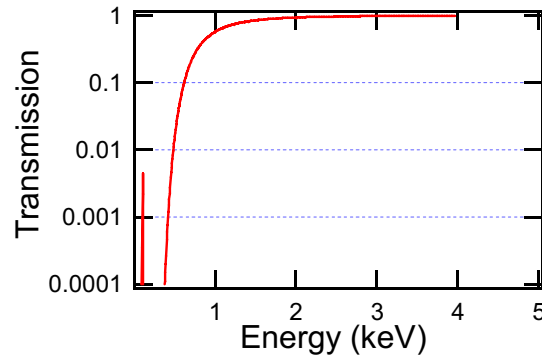
- Imaging and tomographic reconstruction used to analyze plasma activity
 - Oscillatory events (MHD modes, islands)
 - Intermittent events (sawteeth, ELMs, reconnections)
 - Slow phenomena (rotating/locked modes, RWMs)
- Arrays utilize variable filter settings to change plasma region focus
 - 0.3 μm Ti filter views primarily edge C emission
 - 5 μm Be filter passes X-rays from bulk plasma
 - 100 μm Be filter focuses on core plasma emission

Comparison of Filtered X-ray Contribution

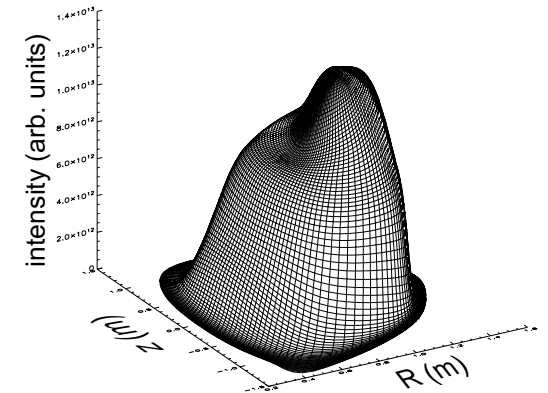
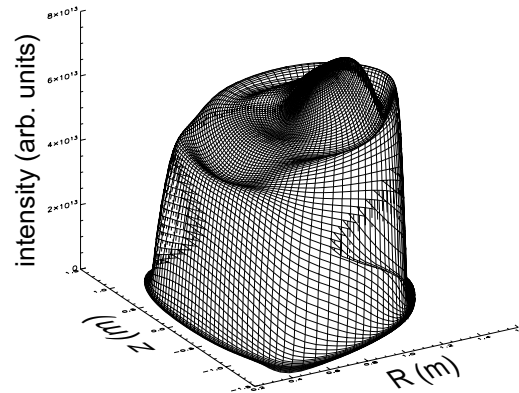
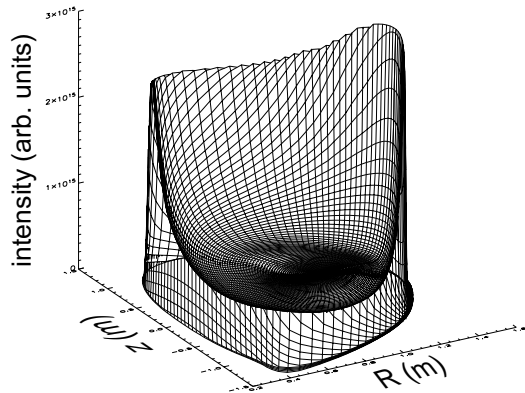
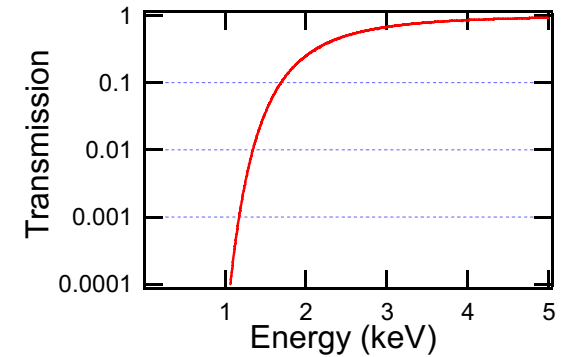
Ti 0.3 μm



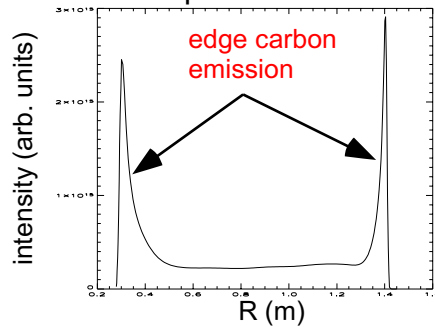
Be 5 μm



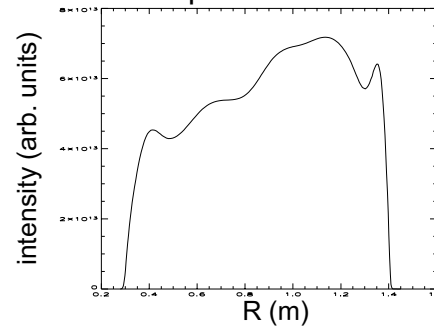
Be 100 μm



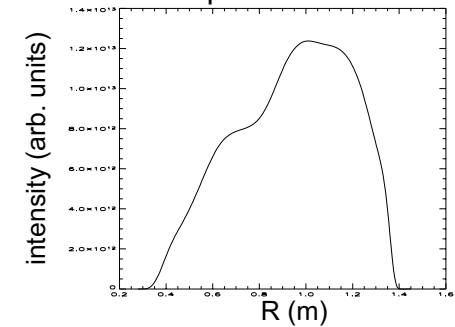
midplane emission



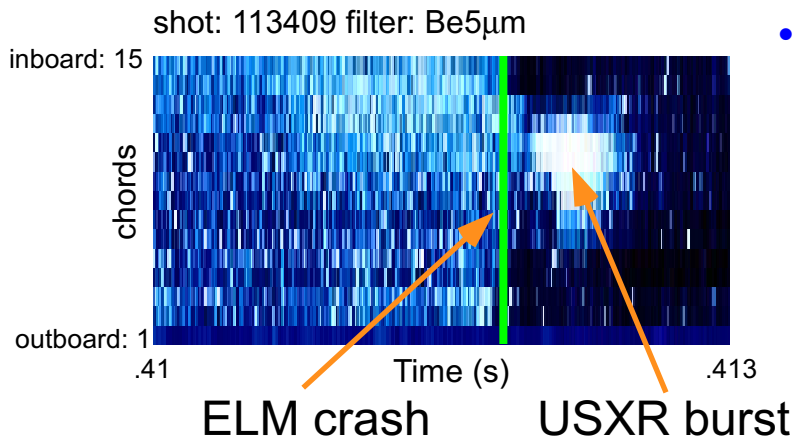
midplane emission



midplane emission



Addition of High-speed Reentrant Array Improves Imaging Capabilities



Localized USXR emission burst
~500 μ s after Type III ELM event

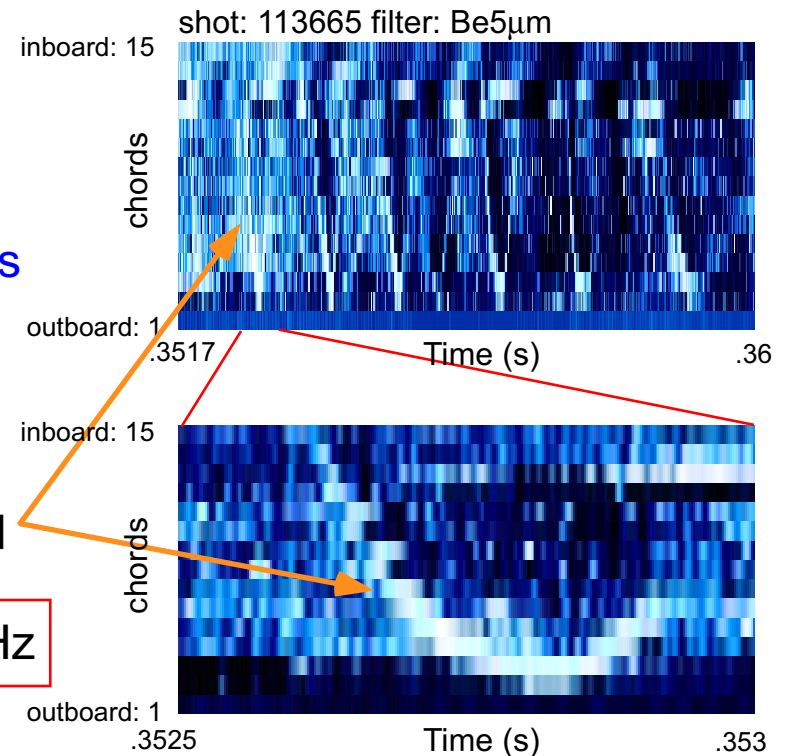
- Fast sampling improves imaging of Type V ELMs

- Reentrant array helps pinpoint ELM origination
- Improves measurement of event propagation

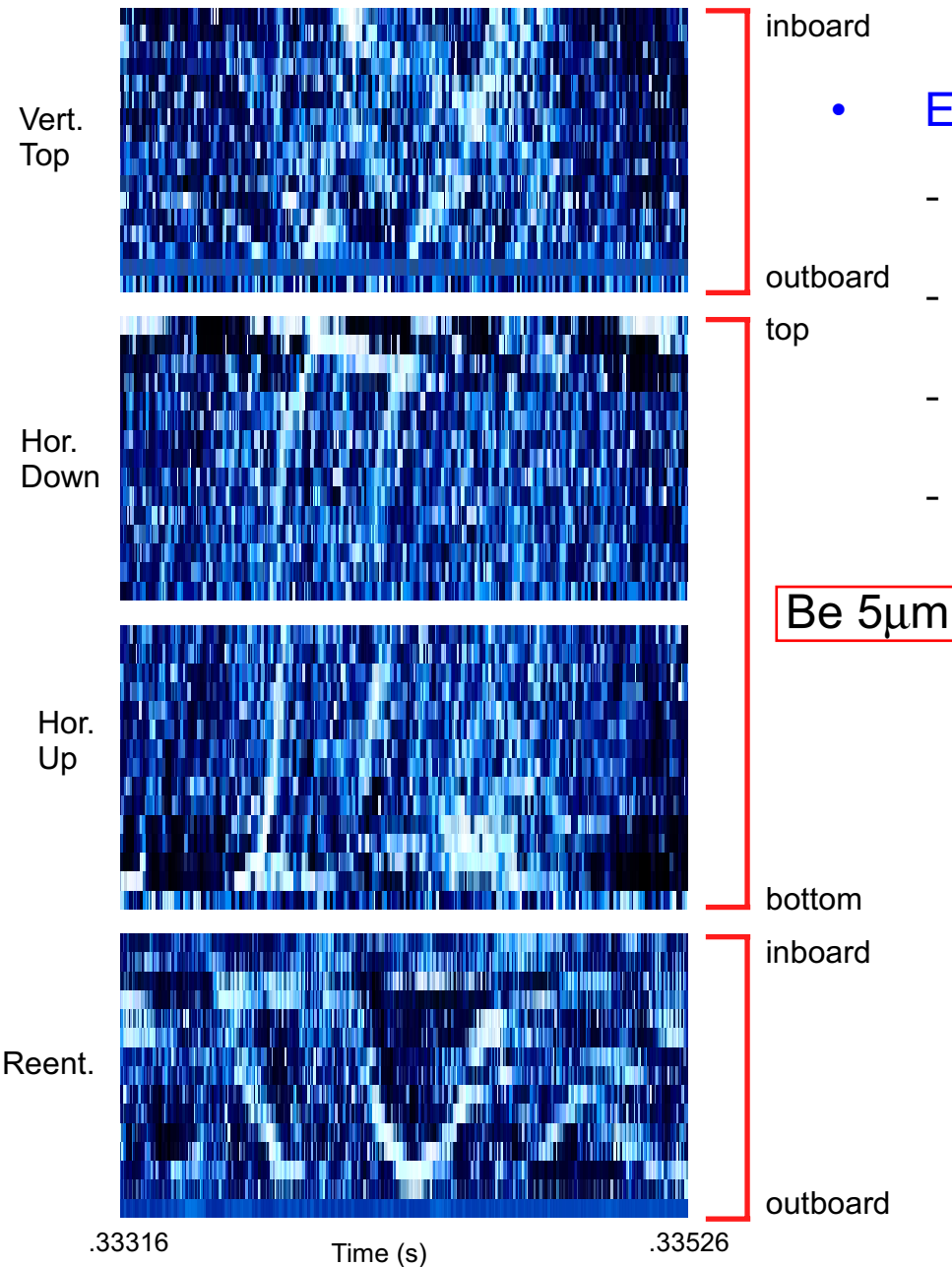
Type V ELM

Reentrant array sampling at 600kHz

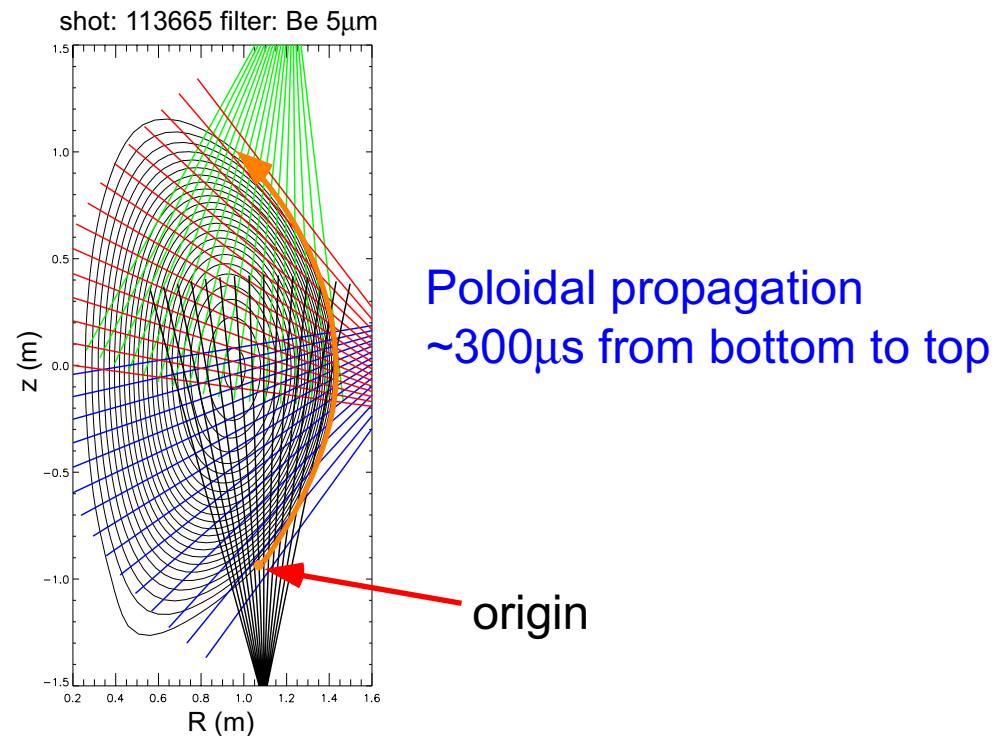
- Reentrant diode array uses AXUV-16 from IRD
 - Fast, low-noise amplifiers have ~300kHz bandwidth
 - High speed PCI digitizer board samples at 600kHz
 - Necessary to resolve outboard plasma edge



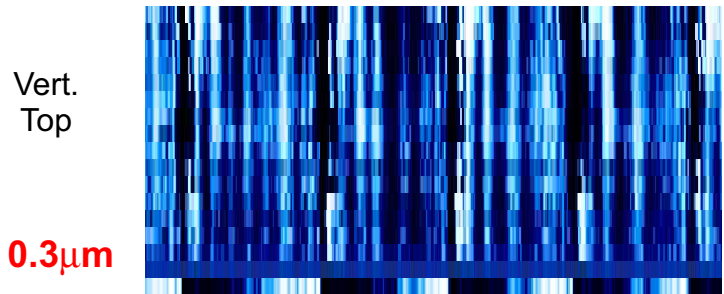
Imaging of Type V ELMs show Poloidal Propagation



- ELM characterized by small edge perturbation
- ELMs originate typically in lower plasma region
- Propagate counter-clockwise poloidally
- Have negligible effect on bulk plasma (T_e , W , ...)
- Regime often contains intermittent Type I events



Type III ELM Correlates with Edge n_e /Impurity Crash

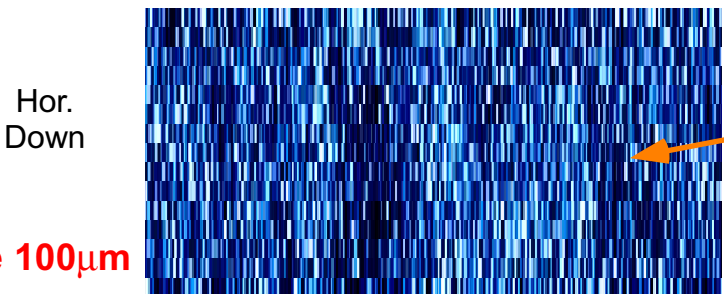


inboard

- USXR data suggests ELM has negligible effect on bulk n_e , T_e

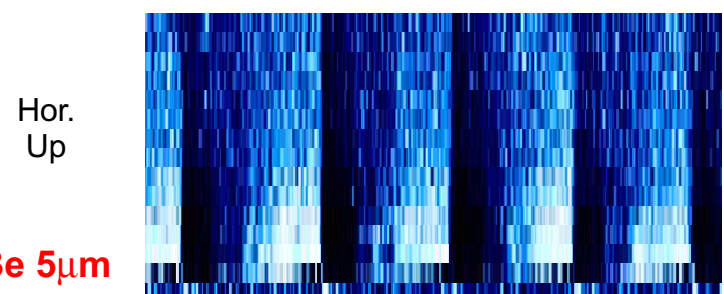
outboard_

Neutron rate unaffected



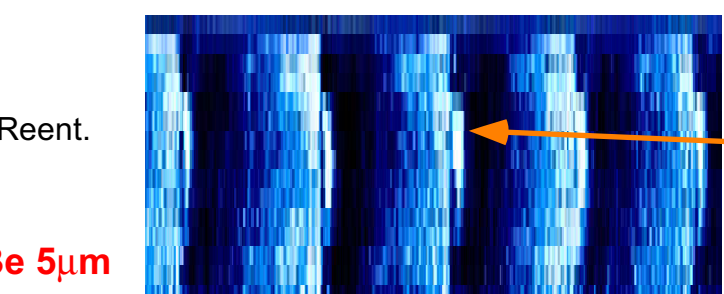
top

- High energy filter shows little/no evidence of ELM



bottom

- ELM frequency increases from $\sim 100\text{Hz}$ to $\sim 300\text{Hz}$ throughout shot (consistent with density increase)



inboard

- Localized USXR emission bloom robust, post-ELM feature

outboard

.3737

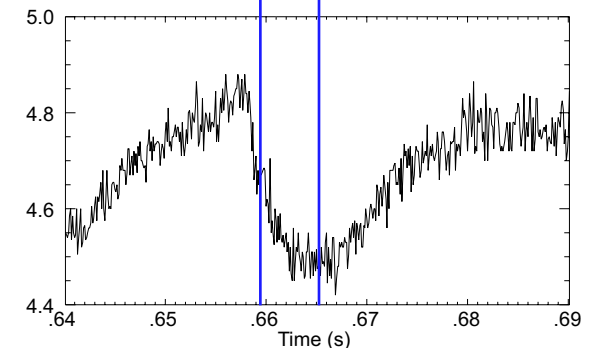
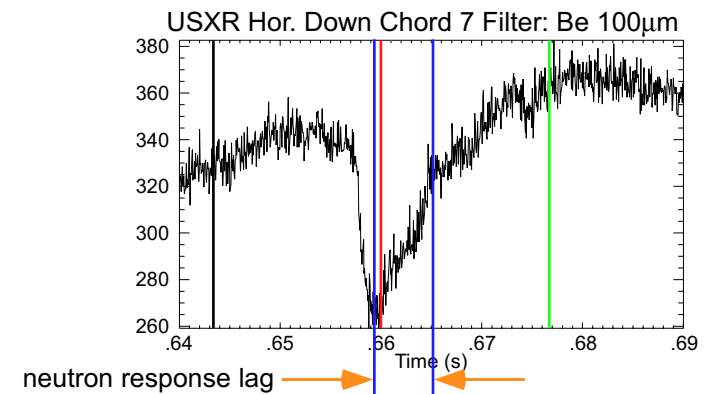
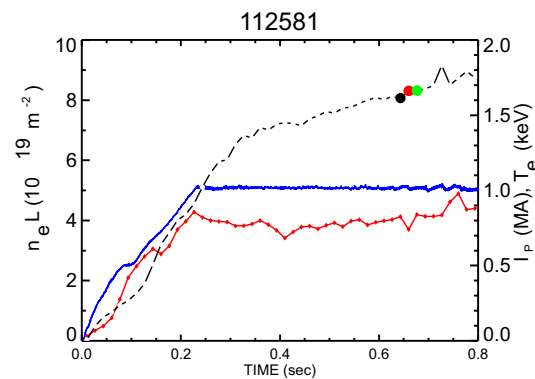
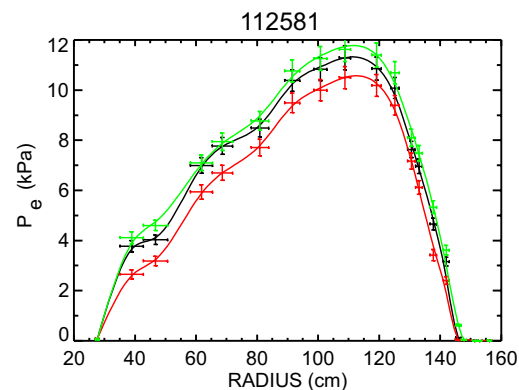
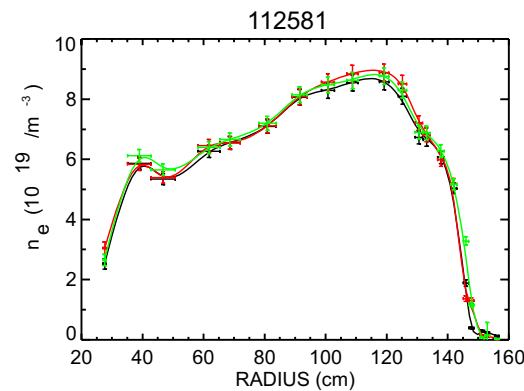
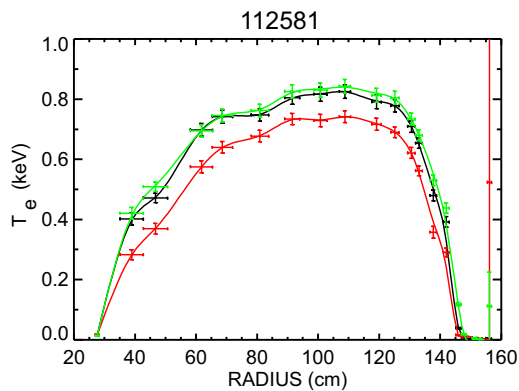
Time (s)

.4

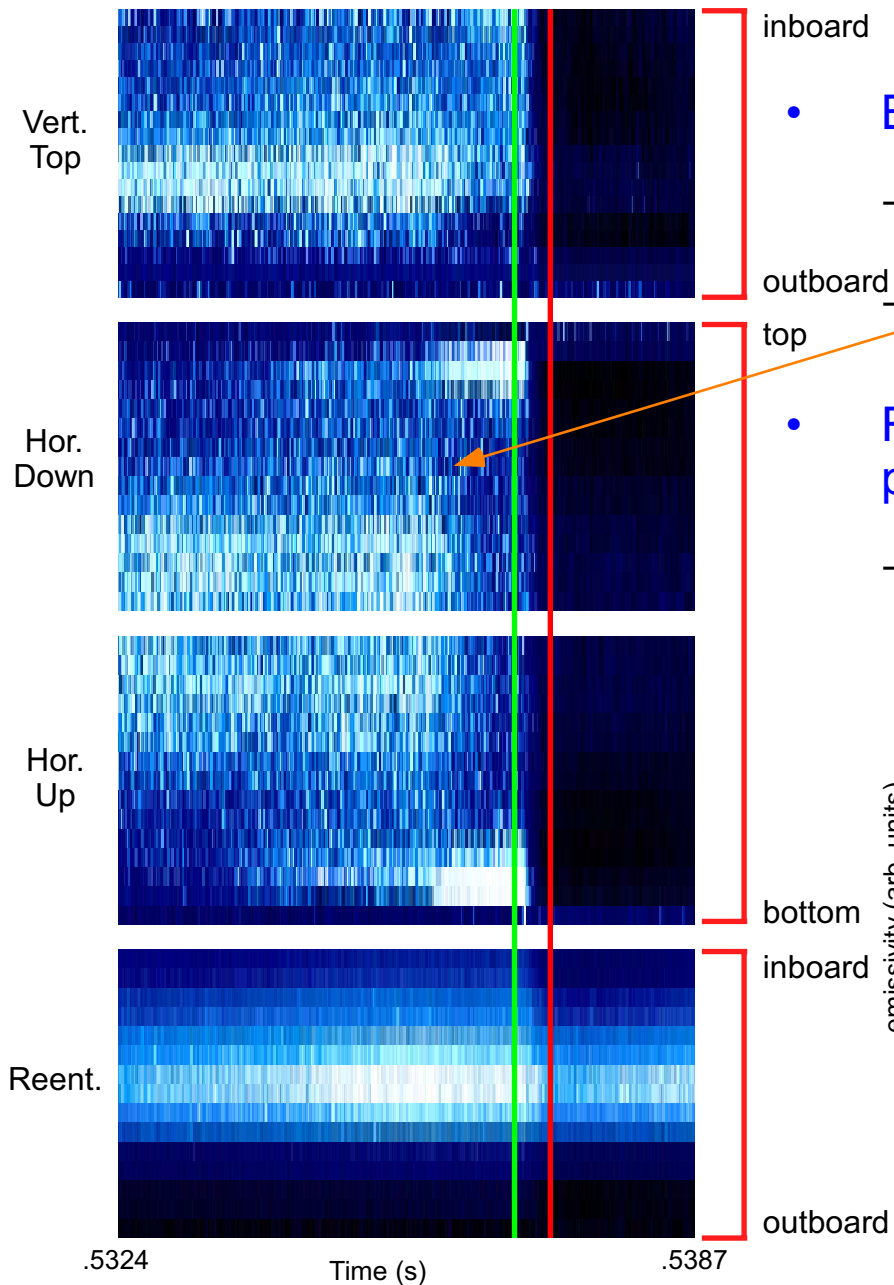
shot# 113406

Type I ELM often Accompanied by Global T_e Perturbation

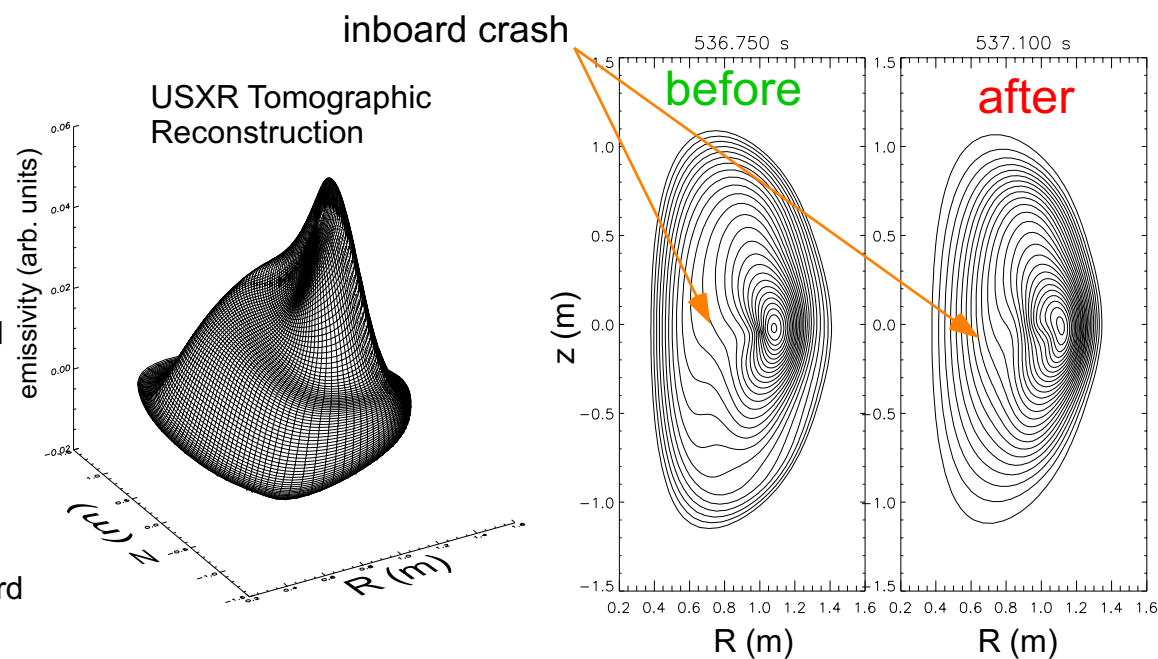
- Thompson measures drop in $T_e(r)$ on the order of 10-20% ($\Delta T_{\text{core}} \sim \Delta T_{\text{edge}}$)
 - n_e measured before, during, and after ELM shows little change (slight peaking?)
pure conductive ELM? (i.e. $n \nabla T$ change only)
 - Neutron response lags T_e profile (decline by $\sim 1\text{ms}$, minimum by $\sim 5\text{ms}$)
 - Not all T_e perturbations reach core (e.g. shot 113665 @ 0.377s, 112581 @ 0.537s)



USXR Arrays Allow Tomographic Reconstruction of Type I ELM Perturbation

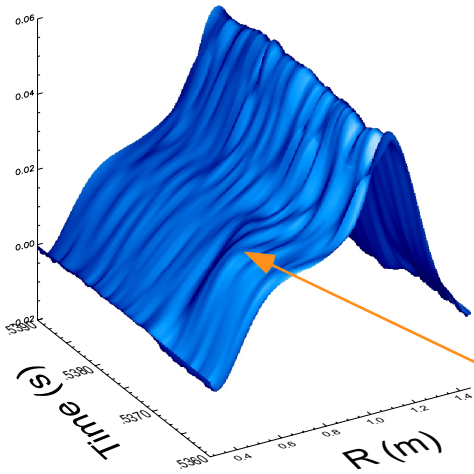


- Be 100 μ m filters focus on core emission
- Reconstructed emissivity consistent with USXR model
- Evidence of redistribution precursor (not always present)
- Reconstructions before and after ELM show main perturbation activity at inboard side of plasma
- Two-color analysis necessary for T_e perturbation study



Preliminary Analysis Indicates Intensity Crash Begins at the Inboard of the Plasma Volume

Reconstructed midplane intensity



- ELM erodes “bump” at inboard of plasma
 - Perturbation reaches $\psi_N \sim 0.25$ (0.7m inboard, 1.27m outboard)
 - Neutron flux drops $\sim 1-3\%$

ELM perturbation

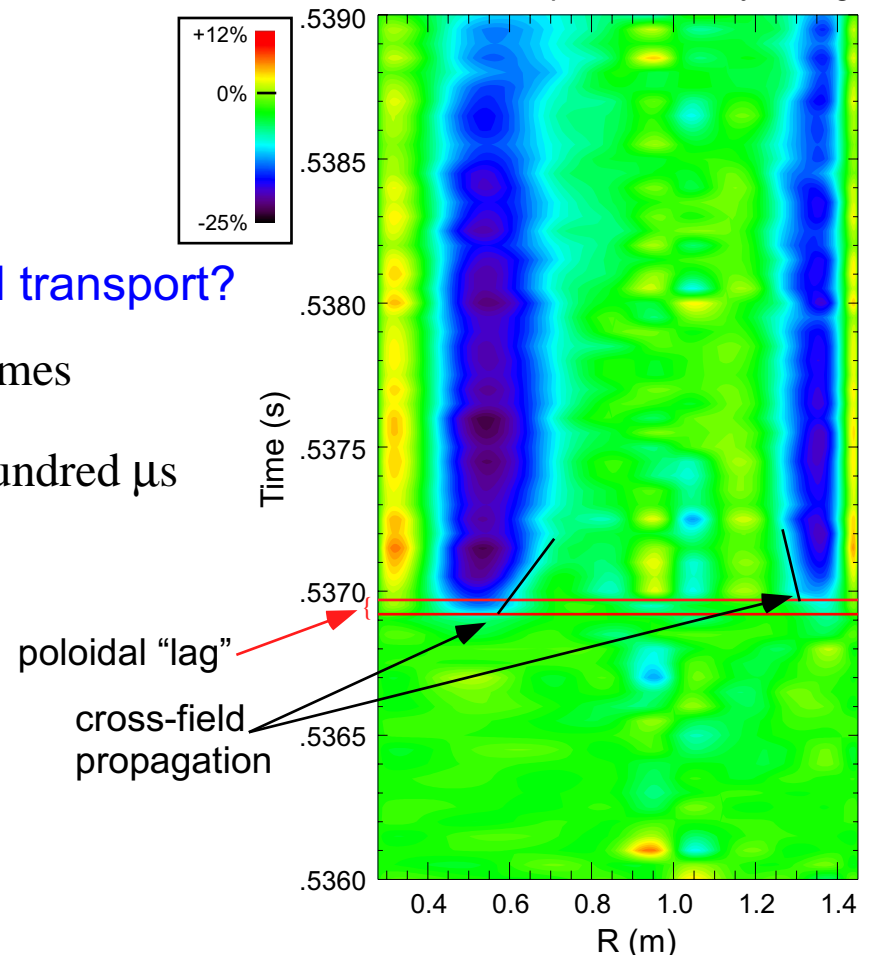
- Delay of outboard crash indicates fast parallel transport?

- $\sim 50\mu\text{s}$ lag consistent with parallel transport times
- Cross-field transport appears slower, \sim few hundred μs

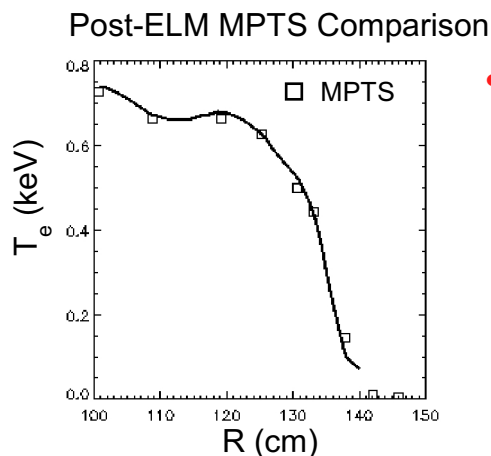
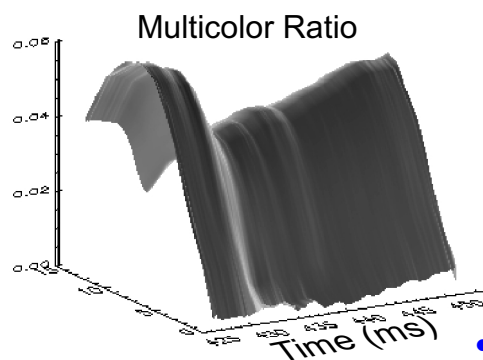
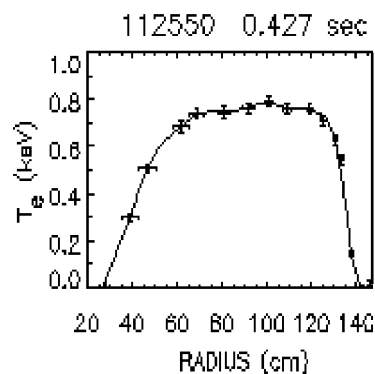
- **Caveat**

- Spatial resolution limited by spline knots
- Time resolution limited by SNR ($\sim 50\mu\text{s}$)
- More events need to be analyzed

Relative midplane intensity change



MPTS T_e profile 'propagated' by 2-color USXR modeling



- Pre-ELM MPTS profiles used to fix n_e , n_z in USXR model
 - USXR profiles modeled using C, O and B coronal equilibrium radiative coefficients and magnetic surface mapping
- Ratio of Be 100 μ m/5 μ m filters sensitive function of T_e
 - 2-color modeling provides $T_e(R,t)$ with good temporal resolution
 - T_e crash in pedestal ~40-80%, core ~10-20% $\left(\frac{\Delta T}{T_{\text{core}}} \neq \frac{\Delta T}{T_{\text{edge}}} \right)$
 - Core perturbation consistent with ~20% reduction in neutron flux
- Propagated $T_e(R)$ matches well with subsequent MPTS profile
- Limitations of technique
 - Crossed arrays allow only 1-D modeling
 - Assumption of no asymmetric density shifts or plasma movement
 - Set of multi-color arrays would alleviate these limitations

Summary

- Upgraded USXR set provides good plasma coverage
 - High-speed reentrant array boosts fast imaging capabilities
 - Some portions of plasma volume still under-sampled
- Various ELM phenomena have been imaged using the USXR arrays
 - imaging of Type V ELMs show poloidal propagation
 - Type III ELMs correlate with edge n_e perturbation and subsequent localized USXR emission bloom
 - Type I ELMs often accompanied by a global T_e perturbation
- Preliminary tomographic reconstruction analysis suggests Type I ELM crash begins at inboard of plasma
- Multi-color USXR modeling is a powerful tool for fast T_e profile analysis